

# Significance of the correction for accidental coincidences in liquid scintillation counting measurements

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Chavdar Dutsov, Benoit Sabot, Philippe Cassette, Krasimir Mitev. Significance of the correction for accidental coincidences in liquid scintillation counting measurements. Journal of Radioanalytical and Nuclear Chemistry, 2022, 331, pp.3303-3311. 10.1007/s10967-022-08316-y. cea-03885861

# HAL Id: cea-03885861 https://cea.hal.science/cea-03885861

Submitted on 6 Dec 2022

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1	Significance of the corrections for accidental
2	coincidences in liquid scintillation counting
3	measurements
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### 11 Abstract

12 Methods for the evaluation of the accidental coincidences counting rates in Triple-to-13 Double Coincidences Ratio (TDCR) Liquid Scintillation (LS) measurements have been 14 proposed recently. This study shows how these corrections can be extended to two 15 detector systems, such as commercial LS counters, or four-detector systems used for the Compton Source Efficiency Tracing (CSET) method. The significance of performing 16 17 corrections for accidental coincidences in low-activity LS counting or TDCR 18 measurements is demonstrated. The impact of accidental coincidences on the 19 determination of half-life of radioisotopes is also shown.

## 20 Keywords

21 accidental coincidences; liquid scintillation counting; radionuclide metrology

### 22 Introduction

23 The aim of this paper is to present experimental results that highlight the significance of 24 the contribution of the accidental coincidences in different types of liquid scintillation 25 counting measurements. Liquid scintillation counting (LSC) is a technique used for the 26 measurement of the activity of radionuclides both in the case of low activities (e.g., <sup>14</sup>C 27 dating, environmental survey, marine studies etc.) and for high activities (measurement of 28 medical radionuclides, etc.) [1]. LSC is generally performed with instruments equipped 29 with two or more photomultiplier tubes (PMTs) connected to coincidence counting 30 circuits. Whenever a coincidence circuit is employed there exists the possibility for two 31 or more unrelated events to occur within the same coincidence window, thus resulting in 32 an accidental coincidence. The theoretical basis for the evaluation of the corrections for 33 accidental coincidences in a LSC system with three PMTs was recently shown in [2]. In 34 this paper the corrections are expanded also to two-detector and four-detector systems. 35 The effects of the accidental coincidences on the measurement of half-lives of 36 radioisotopes, in the case of low-level liquid scintillation counting measurements and in 37 Compton Triple-to-Double Coincidences Ratio (C-TDCR) measurements are shown.

To our knowledge there is are no established procedures for corrections for accidental
coincidences in LSC measurements with commercial devices, two-PMT systems in
general and C-TDCR measurements.

### 41 **Theory**

42 An accidental coincidence occurs when two or more unrelated events are recorded within 43 the same coincidence resolving time (also called 'coincidence window'). By event, it is 44 meant all detected signals that may come from scintillation photons caused by radioactive 45 decay in the sample, from photons caused by interactions of ionizing radiation coming 46 outside the sample (background), from sporadic thermal noise of the photocathode of the 47 PMT, and from electronic noise.

The theoretical basis of the evaluation of the corrections for accidental coincidences is given in [2]. There, analytical equations were proposed to evaluate the counting rate of accidental coincidences in a three PMT liquid scintillation counter. The proposed equations can be easily applied also to a two PMT system by fixing the counting rate of the third PMT in the equations to zero. Thus, for a two PMT system with PMTs A and B the accidental coincidences counting rate  $a_{AB}$  can be evaluated as:

$$p_{A} = n_{A} - n_{AB}$$

$$p_{B} = n_{B} - n_{AB}$$

$$a_{AB} = [2p_{A}p_{B} + (p_{A} + p_{B})p_{AB}]\tau,$$
(1)

where  $\tau$  is the coincidence resolving time,  $n_A$ ,  $n_B$  and  $n_{AB}$  are the counting rates in the single and coincident channels as reported by the detector. The counting rates  $p_A$  and  $p_B$  are the 'pure' single counting rates, meaning the counting rates for events that are single events and are not part of a coincidence.

59 Examining equation (1) there are two terms that constitute the accidental coincidences in 60 a two-PMT system: coincidence between unrelated events in the two PMTs or a single 61 event in any PMT followed by a true coincidence within the same coincidence window. 62 Both terms in the equation depend on the single event counting rates  $p_A$  and  $p_B$ . There are 63 two sources of single events that can be distinguished. One are single events that result 64 from low-energy interactions in the scintillation cocktail and the other is single events 65 that come from the PMT dark noise. For measurements where the activity of the source is 66 low, the predominant source of single events would be the dark noise of the PMT. 67 Therefore, in low-activity measurements, the contribution of the accidental coincidences 68 will be determined from the characteristics of the PMTs. This will also be the case for 69 measurements of blank samples in low-background environments.

70 After the calculation of the counting rate of the accidental coincidences  $a_{AB}$ , the 71 corrected counting rate  $m_{AB}$  is calculated as  $m_{AB} = n_{AB} - a_{AB}$ .

### 72 **Experimental**

# 73 Accidental coincidences in the measurement of half-lives of 74 radionuclides

The half-live of <sup>18</sup>F was studied in this experiment by following the evolution of the 75 76 activity with time. This measurement was performed with a miniature portable TDCR 77 counter. A sample was prepared with 1 mL of radioactive solution ready for injection to a 78 patient (FDG) and dissolved in 10 mL of Ultima Gold LS-cocktail in a glass vial. During this measurement, the counting rates evolves from about 430 000 s<sup>-1</sup> to about 160 s<sup>-1</sup>. The 79 main objective of this study is not the precise determination of the half-life which could 80 81 be used in decay data evaluation, but to illustrate the effect that accidental coincidences 82 could have.

### 83 Accidental coincidences in low-level TDCR measurements

Low-level LSC measurements are commonly used for environmental survey purpose and 84 85 for mandatory monitoring around nuclear activities. These low-level measurements are 86 performed with LSC systems that need to be calibrated with standards of known 87 activities. The activity of the standard sample can be determined using the TDCR method 88 but generally, the activity of the standard is higher than the targeted measurement. Thus, 89 the non-linearity of the detectors may have an impact on the results and, in some case, 90 close to environmental level standards are required for detector calibration. Another case 91 where low-level TDCR measurements can be necessary is for the standardization of some 92 rare nuclides for which it is difficult to have sufficient amount of activity. For low-level 93 measurements, the background is significant compared to the signal from the sample and 94 the contribution of the accidental coincidences to the background counting rates can 95 propagate to the final results through the background correction.

96 In this experiment we have performed measurements of the pure electron capture (EC) 97 nuclide, <sup>53</sup>Mn and of the alpha nuclide, <sup>209</sup>Po (99.55% alpha emissions and 0.45% EC). 98 The measurements of the <sup>53</sup>Mn sample were performed on a miniature portable micro-99 TDCR counter inside a low background shielding (10 cm of low-level lead, 2 mm of 100 cadmium, 2 mm of tin). The counting rate in the logical sum of double coincidences (D)

101 of the blank sample was about  $2.15 \text{ s}^{-1}$  compared to the usually observed 10 s<sup>-1</sup> without 102 shielding. The <sup>209</sup>Po solution is dissolved in 10 ml of Ultima Gold AB cocktail in a 103 polyethylene PTFE coated vial. This sample was measured on the same micro-TDCR 104 counter, but without the low-level shielding.

### 105 Correction for accidental coincidences in C-TDCR measurements

106 In LSC, the primary method that is used for standardization is the TDCR method [3]. The 107 method relies on the correct description of the non-linearity of the light output of the 108 scintillator. Instead of using a traditional semi-empirical relation (the Birks equation [4]), 109 this non-linearity can be directly measured by coupling the TDCR detector to a Compton 110 spectrometer (C-TDCR). A virtual source is created internally in the LS cocktail from an 111 external monoenergetic photon source directed at the vial containing the sample [5, 6]. 112 Some of the photons would experience Compton scattering and some of those scattered 113 photons would be detected by the Compton spectrometer. By gating on a certain energy 114 of the Compton scattered photons one can select a certain energy of the Compton 115 electrons in the cocktail. Then, the light output of the cocktail can be calculated from the 116 LS detector using the TDCR method and the energy of the electron causing the 117 scintillation burst can be deduced from the Compton spectrometer and the energy balance 118 of the Compton effect.

119 One drawback of the C-TDCR methodology is the relatively low detection efficiency of 120 the gamma channel compared to the TDCR channel. This is caused mainly by the 121 difficulty in obtaining high geometrical efficiency of the gamma channel as it requires the 122 use of multiple detectors to cover significant portion of the  $4\pi$  space. In general, the result 123 of this drawback is that a high counting rate is needed in the PMT channels in order to 124 obtain a reasonable counting rate in the gamma channel. The low detection efficiency in 125 combination with high single counting rates can lead to significant contribution of 126 accidental coincidences.

127 The theoretical calculation of the accidental coincidences in a three PMTs counter has 128 been derived in [1]. In principle, the same derivation methodology should be applicable

to a four detectors system as the C-TDCR. In the four detectors system however, there are four single channels, six double coincidence channels, four triple coincidence channels and one quadruple coincidence channel. An analytical equation that accounts for all possible sources of accidental coincidences would be unwieldy and difficult to use in practice. Here we consider another simpler approach that is based on the experimental evaluation of the accidental coincidences again proposed in [1]. The technique relies on the possibility to perform measurements with large coincidence windows (> 2000 ns).

The method consists of performing simultaneous measurements using three coincidence 136 window widths: 1. the coincidence window of interest (e.g., 40 ns or 200 ns), 2000 ns and 137 138 2500 ns. Under the assumption of a uniform time distribution of the accidental 139 coincidences in the time interval of interest it is possible to estimate them from the 140 difference in the counting rates in the 2500 ns and 2000 ns coincidence windows. 141 Another assumption that is made is that at 2000 ns coincidence window width all true 142 coincidences are registered, thus all additional coincidences in a given coincidence 143 channel (ABC, ABG, BCG, etc.) in the 2500 ns are accidental coincidences. The method 144 is schematically illustrated in Fig. 1.

145



Figure 1 Schematic illustration of the method for correction of accidental coincidences in
a four detectors system. The portion of the time interval distribution between 2000 ns and
2500 ns is used to estimate the plateau of the accidental coincidences.

The assumption for the uniform distribution of the accidental coincidences should be applicable to common measurement scenarios. If it can be assumed that the uncorrelated events that constitute the accidental coincidences are a Poisson process, then the time interval between them is exponentially distributed [1]:

 $a(t) = a_0 e^{-\lambda t},$ 

where a(t) is the distribution of accidental coincidences,  $a_0$  is the rate of the accidental coincidences at time t = 0 and  $\lambda$  is the rate of detected events in the coincidence channel. In the case of C-TDCR measurements the coincidence counting rates are less than  $10^3$  s<sup>-1</sup> and the coincidence window is less than 2500 ns. Thus, the argument of the exponent will be less than 2.5 x  $10^{-3}$ . If the exponential distribution is approximated with the linear terms in the Taylor series, the result is:

$$a(t) = a_0(1 - \lambda t).$$

159 Therefore, the deviation from the uniform distribution  $a(t) = a_0$  is negligible and this 160 assumption should be valid.

161 The second assumption of the method is that there are no true coincidences that can be 162 observed for which the separation between the single events is larger than 2000 ns. That 163 is, the scintillation photons that result from one ionizing particle in the sample are 164 grouped in time such that no photon can be emitted after more than 2000 ns after the 165 excitation from the ionizing particle. As organic scintillators and PMTs are fast detector 166 systems this is generally true. It has been shown that 1000 – 1500 ns are enough to 167 capture even photons coming from the delayed fluorescence of the scintillator [7, 8].

### 168 **Results and discussion**

### 169 Accidental coincidences and studies of half-lives

170 In total 72 consecutive 100 s long measurements were performed on the <sup>18</sup>F sample on 171 the miniature TDCR detector. The detection efficiency for this nuclide is relatively high

and is around 99.7%, therefore a large contribution of the accidental coincidences is not expected. A blank sample containing no radioactivity was also measured 64 times for 1000 s. The coincidence window for both sample and blank measurements is 40 ns and the base dead-time duration is 10  $\mu$ s. For the studies of the decay curves with corrected counting rates, both the blank and source measurements were corrected for accidental coincidences.

The use of a three-PMT counter allows the study of the decay curve of the logical sum of the double coincidences (D) and also on the triple coincidences (T). The results of the study are shown in Figure 2. The left figure presents the decay curve following the D coincidences and the right figure the decay curve following the T coincidences. The difference between the corrected and uncorrected counting rates are shown on the bottom plots in percent.



Figure 2 Study of the half-life of <sup>18</sup>F. The decay curve in the left figure is taken from the
D counting rate in the TDCR counter and from the T counting rate in the right figure. The
bottom subplots show the difference between the corrected and uncorrected counting
rates. The values in brackets are the fit uncertainties.

188 There are some interesting observations that can be made from the presented figures.189 Firstly, the accidental coincidences in the D and T channels behave differently. For large

counting rates they are both dominated by accidental coincidences between single and 190 double events caused by <sup>18</sup>F decays and their contribution to the respective channels are 191 192 roughly the same. At low counting rates, however, the accidental coincidences are 193 dominated by single events coming from thermal noise of the PMTs. The probability for 194 triple accidental coincidences in a scenario with mostly single events is negligible and the contribution of the accidentals in that case is close to zero. For the D channel the 195 196 contribution of the accidental coincidences increases significantly and is even larger than in the case of 430 000 s<sup>-1</sup> counting rate. A second observation is that, for both the T and 197 198 D decay curves, the difference between the obtained half-life for corrected and 199 uncorrected counting rates is larger than the fit uncertainties. This shows that even for a very high detection efficiency sample such as <sup>18</sup>F it is necessary to perform corrections 200 201 for accidental coincidences when studying the half-life.

202 A more comprehensive evaluation of the half-life of  ${}^{18}$ F is outside the scope of this paper 203 and will be given elsewhere.

This study serves to illustrate that in some cases the accidental coincidences can be more significant at low counting rates than at extremely high counting rates.

### 206 Accidental coincidences in low-level TDCR measurements

In this experiment we have performed TDCR measurements of samples containing  ${}^{53}$ Mn and  ${}^{209}$ Po. The results from the experiment are presented in Table 1. The coincidence counting rates in the measurements of the radioactive samples are those after subtraction of the counting rates of the blank sample. The  ${}^{53}$ Mn source was measured with 200 ns coincidence window width. The  ${}^{209}$ Po source was measured simultaneously with 40 ns and 400 ns coincidence windows using the nanoTDCR device [9].

Sourco	Coinc.	Counting rate				
Source	window		AB	D	ABC	
	200	No correction	40.590(20)	82.514(27)	18.900(15)	
Mn-53 (EC)		After correction	40.553(20)	82.423(27)	18.889(15)	
		Difference	-0.09%	-0.11%	-0.06%	
	200	No correction	1.646(4)	2.158(5)	1.415(4)	
Blank		After correction	1.640(4)	2.136(5)	1.415(4)	
		Difference	-0.38%	-1.01%	0.00%	
D = 000	40	No correction	9.388(25)	9.785(27)	9.216(25)	
P0-209 (alpha)		After correction	9.369(25)	9.726(26)	9.217(25)	
(aipi ia)		Difference	-0.20%	-0.60%	0.01%	
	40	No correction	9.506(8)	10.466(9)	8.958(8)	
Blank		After correction	9.420(8)	10.305(9)	8.958(8)	
		Difference	-0.90%	-1.53%	0.00%	
D = 000	400	No correction	9.160(40)	9.206(62)	9.163(24)	
P0-209 (alpha)		After correction	9.350(25)	9.797(27)	9.157(24)	
(aipiia)		Difference	2.08%	6.42%	-0.06%	
	400	No correction	10.463(13)	12.075(23)	9.152(8)	
Blank		After correction	9.606(7)	10.474(9)	9.152(8)	
		Difference	-8.20%	-13.26%	0.00%	

213

**Table 1** Low-level measurements of <sup>53</sup>Mn and <sup>209</sup>Po before and after corrections for accidental coincidences. The BC and AC counting rates are omitted as the results are similar to the AB counting rate. The values in brackets are the statistical standard uncertainties calculated as the standard deviation of the mean from ten consecutive measurements of the same sample in the same measurement conditions.

219 A few observations can be made from the results in Table 1. In all measured blank 220 samples, the contribution of the accidental coincidences is significant in the double and 221 logical sum of double coincidences counting rates. In all cases the accidental 222 coincidences in the ABC channel are negligible. This is most probably caused by the low 223 double coincidences counting rates leading to low probabilities of accidental 224 coincidences. Note here that the accidental coincidences in the ABC channel depend on 225 the double coincidences counting rates because of possible detection of unrelated events 226 in the same window such as: for example, unrelated AB and C events leading to a false 227 ABC but also unrelated AB and BC events leading to a false ABC and other such 228 combinations.

Thus the higher the double counting rates, the larger the probability for ABC accidentalcoincidences.

It should also be noted that for <sup>209</sup>Po measurements the counting rates in the double 231 232 coincidences channels decrease after subtracting the accidental coincidences in both the 233 blank sample and the radioactive sample. This is due to the high relative contribution of 234 the accidental coincidences in the blank sample that leads to overestimated blank 235 counting rates before the correction. Comparing the net (background corrected) logical sum of double coincidences (D) counting rates of the two <sup>209</sup>Po measurements it can be 236 seen that there is a 5.9% difference between the uncorrected results at 40 ns (9.785 cps) 237 238 and 400 ns (9.206 cps) coincidence window width. After applying corrections for accidental coincidences the D counting rates become 9.797 s<sup>-1</sup> at 400 ns coincidence 239 window and 9.726 s<sup>-1</sup> at 40 ns coicidence window. Thus the difference between the two 240 241 measurements is reduced to 0.73% after the accidental coincidences correction. Note that 242 this difference could be due to the general increase in the coincidence counting rates that 243 is observed in LSC measurements with increase in the coincidence window width in the case of low-energy emissions [8]. Low-energy emissions that can be detected due to the 244 decay of <sup>209</sup>Po are the X radiations after the EC (probability for EC 0.454%) and the 245 emissions from the 2.239 keV level of <sup>205</sup>Pb that is populated after the alpha decay of 246  $^{209}$ Po [10]. The latter can be observed independently of the alpha decay due to the 24.2 µs 247 248 half-life of the excited state.

These experiments highlight the importance of applying the corrections for accidental coincidences not only for TDCR measurements of high-activity sources, but also in lowlevel measurements.

### 252 Correction for accidental coincidences in C-TDCR measurements

In order to illustrate the importance of the correction for accidental coincidences in C-TDCR measurements we have performed measurements of the relative light output of an Ultima Gold scintillation cocktail. The measurements were performed with a miniature portable TDCR detector system coupled to a CdTe X-Ray detector. The

external source is 74 MBq <sup>241</sup>Am in a steel casing, which provides filtering of the lowenergy emissions. Thus, practically all emissions from the source are from the 59.54 keV line of excited level of <sup>237</sup>Np. The three PMTs of the TDCR counter and the CdTe are connected directly to a CAEN 5751 Desktop Digitizer which digitizes all incoming signals and writes them into list-mode files. These files are later analyzed by a computer software that applies the common dead-time logic [11, 12]. Thus, with this setup it is possible to analyze the same measurement with an arbitrary coincidence window width.

264 Using this experimental setup, a single 72-hour measurement of the Ultima Gold sample 265 was performed. The list-mode data from the measurement was analysed with 40 ns, 266 200 ns, 800 ns, 2000 ns and 2500 ns coincidence window width. The latter two are used 267 to estimate the accidental coincidences. The accidental coincidences per nanosecond of resolving time  $A_0^{(X)}$  in a given coincidence channel X are calculated as the difference 268 269 between coincidence counting rates n in the channel at 2500 ns and 2000 ns coincidence window. The accidental coincidences counting rate  $a^{(x)}$  for the coincidence window of 270 interest  $\tau$  are then obtained as  $a^{(x)} = A_0^{(x)} \tau$ , where  $\tau = 40, 200$  or 800. 271

272 The results of the measurement without and with corrections for accidental coincidences 273 are shown in Fig. 3. Several observations can be made from the presented figures. First, 274 besides the dependence on the coincidence window width, the contribution of the 275 accidental coincidences also largely depends on the deposited energy in the cocktail. For 276 lower energies, the contribution increases and the increase is non-linear. This is caused 277 by the significant reduction in detection efficiency with lower deposited energies which 278 leads to an increase in the ratio of the single events to the detected coincidences. Second, 279 the three measurements agree well with each other when the corrections for accidental 280 coincidences are applied. Some small difference between the long coincidence windows 281 200 ns and 800 ns and the short 40 ns coincidence window remains even after the 282 corrections. This effect is expected as for the 40 ns coincidence window a loss of 283 coincidences is already observed [7, 12, 13].



**Figure 3** Average number of photoelectrons produced at the photocathodes of the PMTs as a function of the energy deposited in the scintillation cocktail. The black line shows a fit of the data from the 40 ns coincidence window with Birks' formula for the nonlinearity of organic scintillators.

Overall, the accidental coincidences are quite significant for the C-TDCR measurements, and especially so for low detection efficiencies. For example, the correction is 3.4% at 3 keV deposited energy at 200 ns coincidence window. It is 0.4% at 40 ns coincidence window and 12.4% at 800 ns coincidence window. For higher energies (higher detection efficiency) the contribution drops to 0.2% at 7 keV (40 ns) and 0.8% (200 ns).

# Discussion about measurements with commercial liquid scintillation counters

The corrections for the accidental coincidences that were proposed in [2] can be used on all detector systems that provide information about the coincidence window width as well as the single and coincident counting rates. Unfortunately, this is not true for the most commonly used commercial liquid scintillation systems, e.g., Quantulus<sup>TM</sup> by PerkinElmer<sup>TM</sup>. These systems are commonly used in scenarios with low counting rates and low detection efficiencies. Both are a prerequisite for having a significant contribution of the accidental coincidences.

302 Despite the impossibility to check the exact value of the contribution of the accidental 303 coincidences in commercial counters it is nevertheless of interest to give estimates in

304 some possible real-word cases. Here we have calculated the contribution of the accidental coincidences for a hypothetical system with 50 ns coincidence window (CW) width that 305 measures samples with coincidence counting rates between  $0.01 \text{ s}^{-1}$  and  $1000 \text{ s}^{-1}$ . It is 306 assumed that the pure single counting rate,  $S_p$ , coming from the sample is 50% from the 307 measured double coincidence counting rate  $D_m$  – such a case is typical for <sup>3</sup>H 308 measurements. Therefore, the measured single counting rate  $S_m$  is:  $S_m = S_0 + S_p = S_0 + S_p$ 309  $0.5D_m$ , where  $S_0$  is the intrinsic dark noise of the PMT. Three cases are considered: 310 commonly observed dark noise of 300 s<sup>-1</sup>, reduced dark noise of 100 s<sup>-1</sup> and greatly 311 reduced dark noise of  $10 \text{ s}^{-1}$ . The latter could possibly be achieved with high signal 312 discrimination thresholds or cooling of the PMTs. Note that the measured single counting 313 314 rates of the two PMTs are assumed to be the same, i. e., the PMTs are assumed to be 315 identical. The double coincidences counting rate after the correction for accidental 316 coincidences  $D_c$  is calculated as: Dc = Dm - a, where a is calculated according to equation (1) substituting  $n_A = n_B = S_0$  and  $n_{AB} = D_m$ . 317

CW, ns	Intrinsic dark noise $S_0$ , s <sup>-1</sup>	Measured singles rate S <sub>m</sub> , s <sup>-1</sup>	Measured doubles rate D <sub>m</sub> , s <sup>-1</sup>	Doubles rate corrected for accidentals $D_{c}$ , s <sup>-1</sup>	(D <sub>m</sub> - D <sub>c</sub> )/D <sub>m</sub>
50	300	300.03	0.02	0.011	45.01%
50	300	300.15	0.1	0.091	9.01%
50	300	301.5	1	0.991	0.91%
50	300	315	10	9.990	0.10%
50	300	450	100	99.984	0.02%
50	300	1800	1000	999.856	0.01%
50	100	100.015	0.01	0.009	10.00%
50	100	100.15	0.1	0.099	1.00%
50	100	101.5	1	0.999	0.10%
50	100	115	10	9.999	0.01%
50	100	250	100	99.996	0.00%
50	100	1600	1000	999.904	0.01%
50	10	10.015	0.01	0.010	0.10%
50	10	10.15	0.1	0.100	0.01%
50	10	11.5	1	1.000	0.00%
50	10	25	10	10.000	0.00%
50	10	160	100	99.999	0.00%
50	10	1510	1000	999.923	0.01%

318 Table 2 Calculations of the contribution of accidental coincidences in a hypothetical two

319 PMT LSC system. Note that the counting rates are given in reciprocal seconds and

320 commercial counters usually report counting rates in reciprocal minutes (counts per321 minute or 'cpm').

The results of this hypothetical experiment are presented in Table 2. Note that for extremely low counting rates (<  $0.1 \text{ s}^{-1}$ ) the contribution of the accidental coincidences is significant in the discussed cases. When the PMT dark noise is reduced to 10 s<sup>-1</sup> the contribution of the accidental coincidences is negligible for counting rates between  $0.1 \text{ s}^{-1}$ and 1000 s<sup>-1</sup>. For more commonly observed cases of the dark noise of the PMTs the contribution of the accidental coincidences can be seen as significant up to 1 s<sup>-1</sup> or 10 s<sup>-1</sup> (60 cpm and 600 cpm respectively).

The information about the counting rates in the individual channels and the width of the coincidence window is important and should be provided to the user even in the case of routine LSC measurements. For example, one commercially available device that provides this data is the nanoTDCR analyzer.

# 333 Low-level measurements with a custom two-PMT liquid scintillation 334 counting system

335 The effect of the accidental coincidences on low-level measurements can be illustrated 336 when using a custom-made two-PMT system with known measurement parameters. This system was used to perform measurements of two samples of <sup>209</sup>Po with approximately 337 338 1 Bq and 60 Bq activity. The two-PMT system consists of two XP2020Q 339 photomultipliers tubes with quartz windows positioned inside an optical chamber at 180° 340 to each other. The shape of the optical chamber was designed and made at LNE-LNHB and is covered with reflective foil (ESR by 3M<sup>TM</sup>). The two PMTs are supplied with 341 342 +2100 V high voltage. Their output signals are processed using labZY nanoTDCR. The 343 nanoTDCR device is used here, instead of a commercial counter, because its signal 344 processing logic and parameters are known and user-selectable, which is not usually the 345 case for commercial counters. The device also allows user-selectable thresholds for both 346 signal inputs. The thresholds for both PMTs are set so that the electronic noise is 347 suppressed as much as possible without sacrificing single-photon sensitivity. The

ananoTDCR also allows simultaneous measurements with two different coincidence windows and two different dead-time base durations. In this experiment the two coincidences windows were set to 40 ns and 200 ns and the dead-time base duration to  $40 \,\mu$ s. The nanoTDCR outputs the single counting rate of each PMT and double coincidences counting rate between PMTs with a known coincidence window and known dead-time base duration [9].

In order to reduce the background and perform low-activity measurements the two-PMT system was placed inside a shielded chamber. The shielding consists of 10 cm of lowlevel lead, 2 mm of cadmium and 2 mm of tin. The chamber was flushed with nitrogen before the measurements to remove radon gas present in the chamber with an average activity concentration of 25 Bq·m<sup>-3</sup> in the laboratory.

The system was used to perform measurements on two samples of <sup>209</sup>Po. The results are 359 shown in Table 3. The value  $n_{AB}$  refers to the double coincidences counting rate before 360 361 any corrections are done. The corrected counting rate  $m_{AB}$  is the net counting rate after subtracting the accidental coincidences in the case of the blank samples. In the case of the 362 samples it is calculated as:  $m_{AB} = \left(n_{AB}^{(Po)} - a_{AB}^{(Po)}\right) - \left(n_{AB}^{(blank)} - a_{AB}^{(blank)}\right)$ 363 polonium  $a_{AB}^{(blank)}$ ). The values in brackets are the standard uncertainties calculated as the standard 364 deviation of the mean taken from 10 consecutive measurements of the same sample in the 365 366 same conditions.

Sample	CW, ns	PMT A single counting rate, s <sup>-1</sup>	PMT B single counting rate, s <sup>-1</sup>	Before correction n <sub>AB</sub> , s <sup>-1</sup>	Rate of accidental coinc. <i>a</i> <sub>AB</sub> , s <sup>-1</sup>	Corrected counting rate m <sub>AB</sub> , s <sup>-1</sup>	(m <sub>ab</sub> - n <sub>ab</sub> )/n <sub>ab</sub>
<sup>209</sup> Po (~1 Bq)	40	187.5(17)	645.0(91)	1.0635(47)	0.0101	1.0534(46)	-0.95%
<sup>209</sup> Po (~1 Bq)	200	187.5(17)	645.0(91)	1.1064(53)	0.0508	1.0556(47)	-4.59%
<sup>209</sup> Po (~60 Bq)	40	304.7(96)	960(43)	63.680(98)	0.06	63.686(98)	0.01%
<sup>209</sup> Po (~60 Bq)	200	304.7(96)	960(43)	63.834(98)	0.028	63.862(98)	0.04%
Blank	40	200.9(94)	660.4(111)	0.5336(16)	0.0131	0.5205(16)	-2.46%
Blank	200	200.9(94)	660.4(111)	0.6201(21)	0.0657	0.5544(15)	-10.60%

Table 3 Calculations of the contribution of accidental coincidences in the two PMT LSC system for the two samples of <sup>209</sup>Po and the blank sample used for background correction. Note that the <sup>209</sup>Po counting rates are background corrected and 'before

370 correction' and 'corrected' refers to the correction for accidental coincidences. The same

371 blank measurement was used for background correction for both <sup>209</sup>Po samples.

372 The measurements in Table 3 show that both PMTs are not identical and PMT B has 373 higher single counting rate probably due to higher intrinsic thermal noise. In the case of the measurement of the blank sample and the 1 Bq <sup>209</sup>Po sample the major contributing 374 375 factor to the accidental coincidences would be the thermal noise of the PMTs. While the 376 counting rate of the accidental coincidences caused by the thermal noise is very low (0.0101 s<sup>-1</sup> at 40 ns coincidence window and 0.0508 s<sup>-1</sup> at 200 ns) it is significant 377 compared to the low true counting rates of the source and blank samples. The 378 coincidence counting rate of the 1 Bq <sup>209</sup>Po sample is 0.95% lower after correction for 379 accidental coincidences for the 40 ns coincidence window measurement and 2.46% lower 380 381 for the 200 ns coincidence window measurement. It should also be noted that the 382 corrected coincidence counting rates obtained with the longer window are significantly 383 higher than those with the short window. This shows that some coincidences are lost if 384 the short 40 ns coincidence window is used. Therefore, the effect of the accidental 385 coincidences cannot be reduced by simply using a shorter coincidence window as this would lead to loss of true coincidences also. In the case of the higher activity <sup>209</sup>Po 386 387 source, the contribution of the accidental coincidences to the background corrected 388 coincidence counting rate is negligible.

389 These experiments serve to show the importance of applying corrections for accidental 390 coincidences in the case of low-activity measurements. To do that, the use of a signal 391 processing unit that gives information about the coincidence window and the single 392 counting rates is mandatory.

### 393 Conclusions

These experiments highlight the importance of applying the corrections for accidental coincidences not only for measurements of high-activity sources, but also in low-level LSC measurements. The performed C-TDCR measurements show that the accidental coincidences must be considered in all cases and applying corrections is mandatory if

398 correct results are to be obtained. The hypothetical measurements with commercial LSC 399 systems indicate that the accidental coincidences can be significant in some cases. 400 Unfortunately, most of the commercial LSC counters are black boxes and do not allow 401 the estimation of the accidental coincidences due to the lack of important data such as the 402 coincidence window width that is used or the single PMT counting rates. LSC systems 403 that provide information of the single counting rates and used coincidence window width 404 and dead-time logic should be preferred in cases where accurate measurements are 405 needed.

### 406 Acknowledgements

407 This work is supported by the Bulgarian National Scientific Research Fund under 408 contract KP-06-H38/9 from 06.12.19 (TDCX).

409 The authors thank Dr Philippe Gervais from CEA/SHFJ for providing sample of <sup>18</sup>F
410 solution. This work was funded by the French national metrology institute: Laboratoire
411 National de Métrologie et d'Essais (LNE).

412 The authors are indebted to Dr Karsten Kossert for providing the <sup>53</sup>Mn sample.

The measurement of Po-209 samples were performed in the framework of DORN
 project. The authors thank Margot Corbel from CEA/LNHB for the preparation of the
 <sup>209</sup>Po sample.

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